

TRANSMITTAL LETTER TO THE UNITED STATES

DESIGNATED/ELECTED OFFICE (DO/EO/US)

ATTORNEY'S DOCKET NUMBER

7426-0067

097402274 ✓

520 Rec'd PCT/PTO 30 SEP 1999 ✓

INTERNATIONAL APPLICATION NO.
PCT/JP98/01467

INTERNATIONAL FILING DATE
March 31, 1998

PRIORITY DATE CLAIMED
March 31, 1997; September 18, 1997

TITLE OF INVENTION

CIRCUIT-CONNECTING MATERIAL AND CIRCUIT TERMINAL CONNECTED STRUCTURE AND CONNECTING METHOD

APPLICANT(S) FOR DO/EO/US

Itsumo WATANABE, Tohru FUJINAWA, Motohiro ARIFUKU, Houko KANAZAWA and Atsushi KUWANO ✓

Applicant herewith submits to the United States Designated/ Elected Office (DO/EO/US) the following items under 35 U.S.C. 371:

1. ☒ This is a **FIRST** submission of items concerning a filing under 35 U.S.C. 371.
2. ☐ This is a **SECOND** or **SUBSEQUENT** submission of items concerning a filing under 35 U.S.C. 371.
3. ☒ This express request to begin national examination procedures (35 U.S.C. 371(f)) at any time rather than delay examination until the expiration of the applicable time limit set in 35 U.S.C. 371(b) and PCT Articles 22 and 39(1).
4. ☐ A proper Demand for International Preliminary Examination was made by the 19th month from the earliest claimed priority date.
5. ☒ A copy of the International Application as filed (35 U.S.C. 371(c)(2))
 - a. ☐ is transmitted herewith (required only if not transmitted by the international Bureau).
 - b. ☒ has been transmitted by the International Bureau.
 - c. ☐ is not required, as the application was filed in the United States Receiving Office (RO/US)
6. ☒ A translation of the International Application into English (35 U.S.C. 371(c)(2)).
7. ☐ Amendments to the claims of the International Application under PCT Article 19 (35 U.S.C. 371(c)(3))
 - a. ☐ are transmitted herewith (required only if not transmitted by the International Bureau).
 - b. ☐ have been transmitted by the International Bureau.
 - c. ☐ have not been made; however, the time limit for making such amendments has NOT expired.
 - d. ☐ have not been made and will not be made.
8. ☒ A translation of the amendments to the claims under PCT Article 34 filed on November 17, 1998.
9. ☒ An unsigned oath or declaration of the inventor(s) (35 U.S.C. 371(c)(4)).
10. ☐ A translation of the annexes to the International Preliminary Examination Report under PCT Article 36 (35 U.S.C. 371(c)(5)).

Items 11. to 16. below concern document(s) or information included:

11. ☒ An Information Disclosure Statement under 37 CFR 1.97 and 1.98.
12. ☐ An assignment document for recording. A separate cover sheet in compliance with 37 CFR 3.28 and 3.31 is included.
13. ☒ A **FIRST** preliminary amendment.
☐ A **SECOND** or **SUBSEQUENT** preliminary amendment.
14. ☐ A substitute specification.
15. ☐ A change of power of attorney and/or address letter.
16. ☒ Other items or information:

Copies of: the Front Page of PCT Publication WO 98/44067; Form PCT/ISA/210 with English translation; Form PCT/IPEA/409 and PCT/IPEA/416 with English translation.



09/402274

17. ☒ The U.S. National Fee (35 U.S.C. 371(c)(1)) and other fees as follows:

420 Rec'd PCT/PTO 30 SEP 1999

CLAIMS

(1)FOR	(2)NUMBER FILED	(3)NUMBER EXTRA	(4)RATE	(5)CALCULATIONS
TOTAL CLAIMS	31 - 20	11	X \$ 18.00	\$ 198.00
INDEPENDENT CLAIMS	4 - 3	1	X \$ 78.00	78.00

MULTIPLE DEPENDENT CLAIM(S) (if applicable)

+ \$ 260.00

□

BASIC NATIONAL FEE (37 CFR 1.492(a)(1)-(5)):

CHECK ONE BOX ONLY

☐ International preliminary examination fee paid to USPTO (37 CFR 1.482)

\$ 670

☐ No international preliminary examination fee paid to USPTO (37 CFR 1.482) but international search fee paid to USPTO (37 CFR 1.445(a)(2))

\$ 760

☐ Neither international preliminary examination fee (37 CFR 1.482) nor international search fee (37 CFR 1.445(a)(2)) paid to USPTO

\$ 970

☐ International preliminary examination fee paid to USPTO (37 CFR 1.482) and all claims satisfied provisions of PCT Article 33(2) to (4)

\$ 96

☒ Filing with EPO or JPO search report

\$ 840

\$ 840.00

Surcharge of \$130.00 for furnishing the National fee or oath or declaration later than 20 30 mos. from the earliest claimed priority date (37 CFR 1.492(e)).

TOTAL OF ABOVE CALCULATIONS

= 1,116.00

Reduction by 1/2 for filing by small entity, if applicable. Affidavit must be filed also. (Note 37 CFR 1.9, 1.27, 1.28).

- \$ 0.00

SUBTOTAL

= 1,116.00

Processing fee of \$130.00 for furnishing the English Translation later than 20 30 mos. from the earliest claimed priority date (37 CFR 1.492(f)).

+ 1,116.00

TOTAL FEES ENCLOSED \$ 1,116.00

- a. ☐ A check in the amount of \$__ to cover the above fees is enclosed.
- b. ☐ Please charge Deposit Account No. 16-1150 in the amount of \$ 1,116.00 to cover the above fees. A copy of this sheet is enclosed.
- c. ☒ The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment to Deposit Account No. 16-1150. A copy of this sheet is enclosed.

18. ☐ Other instructions

19. ☒ All correspondence for this application should be mailed to
PENNIE & EDMONDS LLP
1155 AVENUE OF THE AMERICAS
NEW YORK, NEW YORK 10036-2711

20. ☒ All telephone inquiries should be made to (212) 790-2803Charles E. Miller
NAME

SIGNATURE

24,576

REGISTRATION NUMBER

September 30, 1999
DATE

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of: Itsuo WATANABE et al.

Application No.: To be assigned

Group Art Unit: To be assigned

Filed: September 30, 1999

Examiner: To be assigned

For: CIRCUIT-CONNECTING
MATERIAL AND CIRCUIT
TERMINAL CONNECTED
STRUCTURE AND CONNECTING
METHOD

Attorney Docket No.: 7426-0067

PRELIMINARY AMENDMENT

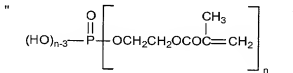
Assistant Commissioner for Patents
Washington, D.C. 20231

Sir:

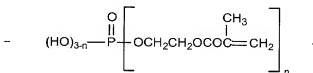
Applicants request consideration and entry of the following amendments prior
to examination of the above-identified application.

IN THE SPECIFICATION:

Page 4, line 4, change formula



to



Page 8, lines 6-7, change "circuit electrode" to --connecting terminal--.

line 13, change "provisional" to --main--.

Page 9, line 5, after "are", add --more--.

Page 11, line 9, change "di-2-ethoxymethoxyperoxydicarbonate" to --di(2-ethoxyethyl) peroxydicarbonate--.

line 10, change "di(2-ethylhexylperoxy)dicarbonate" to --di(2-ethylhexyl) peroxydicarbonate--.

lines 10-11, change "dimethoxybutyl peroxydicarbonate" to --di(3-methoxybutyl) peroxydicarbonate--.

line 12, change "di(3-methyl-3-methoxybutylperoxy)dicarbonate" to --di(3-methyl-3-methoxybutyl) peroxydicarbonate--.

line 18, change "1,1-(t-butylperoxy)cyclododecane" to --1,1-bis(t-butylperoxy)cyclododecane--.

Page 13, line 25, change "2,2-bis[3-s-butyl-4-8(4-maleimidophenoxy)phenyl]propane" to --2,2-bis[3-s-butyl-4-(4-maleimidophenoxy)phenyl]propane--.

Page 20, line 2, change "4,4'-(phenylmethylene)bis-2,3,5-trimethylphenol" to --4,4'-(phenylmethylene)bis(2,3,5-trimethylphenol)--.

line 8-9, change "4-hydroxy- α -(4-hydroxyphenyl)- α -methylbenzene acetic acid methyl ester" to --4-hydroxy- α -(4-hydroxyphenyl)- α -methylbenzene acetic acid methyl ester--.

lines 10-11, change "4-hydroxy- α -(4-hydroxyphenyl)- α -methylbenzene acetic acid ethyl ester" to --4-hydroxy- α -(4-hydroxyphenyl)- α -methylbenzene acetic acid ethyl ester--.

Page 21, line 11, change "4,4'-cyclohexylidene[2,6-dimethylphenol]" to --4,4'-cyclohexylidenebis[2,6-dimethylphenol]--.

Page 22, line 23, change "2,2'-methylidenebis(2,4-di-t-butyl-5-methylphenol)" to --2,2'-methylidenebis[2,4-di(t-butyl)-5-methylphenol]--.

Page 31, line 19, change "sealing modling" to --circuit-connecting--.

Page 33, line 12, change "H1-NMR" to --¹H-NMR--.

Page 39, line 17, after "plastics", add --etc.--.

Page 44, line 23, change "silicone" to --silicon--.

Page 51, line 12, change "dimethacrylate, phosphate" to --dimethacrylate/phosphate--.

line 26, change "dimethacrylate, phosphate" to --dimethacrylate/phosphate--.

Page 53, lines 4-5, change ".phosphate" to --/phosphate--.

line 16, change "acrylate, phosphate" to --acrylate/phosphate--.

Page 54, line 1, change "isocyanurate, phosphate" to --isocyanurate/phosphate--.

Page 56, line 9, change "40/20/40" to --40g/20g/40g--.

Page 58, line 10, change "109" to --10⁹--.

IN THE CLAIMS

Please cancel claims 3-7 and 10-22.

Please add new claims 23-49 as follows:

--claim 23. (new) A circuit terminal connecting method comprising:

disposing a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, in such a way that the first connecting terminal and the second connecting terminal face each other and interposing a circuit-

connecting material capable of curing upon radical polymerization, between the first connecting terminal and the second connecting terminal which face each other, followed by heating and pressing to electrically connect the first connecting terminal and the second connecting terminal which face each other, wherein:

a surface of at least one of said first and second connecting terminals being formed of a metal selected from gold, silver, tin and platinum group metals; and said circuit-connecting material capable of curing upon radical polymerization being formed on one connecting terminal whose surface is formed of the metal selected from gold, silver, tin and platinum group metals, and thereafter the other connecting terminal being registered, followed by the heating and pressing to connect them.

claim 24. (new) The circuit terminal connected structure comprising a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, wherein:

said circuit members being disposed in such a way that the first connecting terminal and the second connecting terminal face each other; a circuit-connecting material capable of curing upon radical polymerization being interposed between the first connecting terminal and the second connecting terminal which face each other; the surface of at least one of the first and second connecting terminals being formed of a metal selected from gold, silver, tin and platinum group metals; the first connecting terminal and the second connecting terminal which face each other being electrically connected; and said circuit-connecting material capable of curing upon radical polymerization is the circuit-connecting material according to claim 1.

claim 25. (new) The circuit terminal connected structure comprising a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, wherein:

said circuit members being disposed in such a way that the first connecting terminal and the second connecting terminal face each other; a circuit-connecting material capable of curing upon radical polymerization being interposed between the first connecting terminal and the second connecting terminal which face each other; the surface of at least one of the first and second connecting terminals being formed of a metal selected from gold, silver, tin and platinum group metals; the first connecting terminal and the second connecting terminal which face each other being electrically connected; and said circuit-connecting material capable of curing upon radical polymerization is the circuit-connecting material according to claim 8.

claim 26. (new) The circuit terminal connecting method comprising:

disposing a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, in such a way that the first connecting terminal and the second connecting terminal face each other and interposing a circuit-connecting material capable of curing upon radical polymerization, between the first connecting terminal and the second connecting terminal which face each other, followed by heating and pressing to electrically connect the first connecting terminal and the second connecting terminal which face each other, wherein:

a surface of at least one of said first and second connecting terminals being formed of a metal selected from gold, silver, tin and platinum group metals; said circuit-connecting material capable of curing upon radical polymerization being formed on one connecting

terminal whose surface is formed of the metal selected from gold, silver, tin and platinum group metals, and thereafter the other connecting terminal being registered, followed by the heating and pressing to connect them; and said circuit-connecting material capable of curing upon radical polymerization is the circuit-connecting material according to claim 1.

claim 27. (new) The circuit terminal connecting method comprising:

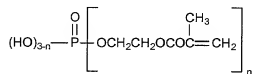
disposing a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, in such a way that the first connecting terminal and the second connecting terminal face each other and interposing a circuit-connecting material capable of curing upon radical polymerization, between the first connecting terminal and the second connecting terminal which face each other, followed by heating and pressing to electrically connect the first connecting terminal and the second connecting terminal which face each other, wherein:

a surface of at least one of said first and second connecting terminals being formed of a metal selected from gold, silver, tin and platinum group metals; said circuit-connecting material capable of curing upon radical polymerization being formed on one connecting terminal whose surface is formed of the metal selected from gold, silver, tin and platinum group metals, and thereafter the other connecting terminal being registered, followed by the heating and pressing to connect them; and said circuit-connecting material capable of curing upon radical polymerization is the circuit-connecting material according to claim 8.

claim 28. (new) The circuit-connecting material according to claim 1, wherein said hydroxyl-group-containing resin is at least one of polyvinyl butyral, polyvinyl formal, polyamide, polyester, phenol resin, epoxy resin and phenoxy resin .

claim 29. (new) The circuit-connecting material according to claim 8, wherein said radical-polymerizable substance comprises a maleimide compound having at least two maleimide groups in a molecule.

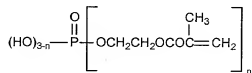
claim 30. (new) The circuit-connecting material according to claim 29, wherein said radical-polymerizable substance further comprises a radical-polymerizable substance represented by the following chemical formula (a):



... (a)

wherein n is an integer of 1 to 3.

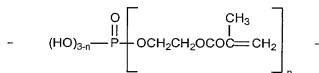
claim 31. (added) The circuit-connecting material according to claim 8, wherein said radical-polymerizable substance comprises a radical-polymerizable substance represented by the following chemical formula (a):



wherein n is an integer of 1 to 3.

claim 32. (new) the circuit-connecting material according to claim 1, wherein said curing agent capable of generating free radicals upon heating is a peroxyester.

claim 33. (new) The circuit-connecting material according to claim 1, wherein said radical-polymerizable substance comprises a radical-polymerizable substance represented by the following chemical formula (a):



... (a)

wherein n is an integer of 1 to 3.

claim 34. (new) The circuit-connecting material according to claim 1, wherein said hydroxyl-group-containing resin having a molecular weight of 10,000 or more is a phenoxy resin.

claim 35. (new) The circuit-connecting material according to claim 1, wherein said hydroxyl-group-containing resin having a molecular weight of 10,000 or more is a phenoxy resin modified with a carboxyl-group-containing elastomer.

claim 36. (new) The circuit-connecting material according to claim 1, wherein said hydroxyl-group-containing resin having a molecular weight of 10,000 or more is a phenoxy resin modified with an epoxy-group-containing elastomer.

claim 37. (new) The circuit-connecting material according to claim 1, which contains an acrylic rubber.

claim 38. (new) The circuit-connecting material according to claim 8, which contains an acrylic rubber.

claim 39. (new) A circuit-connecting material which is interposed between circuit electrodes facing each other and electrically connects the electrodes in the pressing direction by pressing the facing electrodes against each other, wherein:

said circuit-connecting material having, in a measurement with a differential scanning calorimeter (DSC) at 10°C/min., an exothermic reaction arising temperature (Ta) within a range of from 70°C to 110°C, a peak temperature (Tp) of Ta + 5 to 30°C and an end temperature (Te) of 160°C or below.

claim 40. (new) The circuit-connecting material according to claim 1, which contains conductive particles.

claim 41. (new) The circuit-connecting material according to claim 8, which contains conductive particles.

claim 42. (new) The circuit-connecting material according to claim 12, which contains conductive particles.

claim 43. (new) A circuit terminal connected structure comprising a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, wherein:

said circuit members being disposed in such a way that the first connecting terminal and the second connecting terminal face each other; the circuit-connecting material according to claim 1 being interposed between the first connecting terminal and the second connecting terminal which face each other; and the first connecting terminal and the second connecting terminal which face each other being electrically connected.

claim 44. (new) A circuit terminal connected structure comprising a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, wherein:

said circuit members being disposed in such a way that the first connecting terminal and the second connecting terminal face each other; the circuit-connecting material according to claim 8 being interposed between the first connecting terminal and the second connecting terminal which face each other; and the first connecting terminal and the second connecting terminal which face each other being electrically connected.

claim 45. (new) A circuit terminal connected structure comprising a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, wherein:

said circuit members being disposed in such a way that the first connecting terminal and the second connecting terminal face each other; the circuit-connecting material according to claim 12 being interposed between the first connecting terminal and the second connecting

terminal which face each other; and the first connecting terminal and the second connecting terminal which face each other being electrically connected.

claim 46. (new) A circuit terminal connecting method comprising:

disposing a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, in such a way that the first connecting terminal and the second connecting terminal face each other and interposing the circuit-connecting material according to claim 1, between the first connecting terminal and the second connecting terminal which face each other, followed by heating and pressing to electrically connect the first connecting terminal and the second connecting terminal which face each other.

claim 47. (new) A circuit terminal connecting method comprising:

disposing a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, in such a way that the first connecting terminal and the second connecting terminal face each other and interposing the circuit-connecting material according to claim 8, between the first connecting terminal and the second connecting terminal which face each other, followed by heating and pressing to electrically connect the first connecting terminal and the second connecting terminal which face each other.

claim 48. (new) A circuit terminal connecting method comprising:

disposing a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, in such a way that the first connecting

terminal and the second connecting terminal face each other and interposing the circuit-connecting material according to claim 12, between the first connecting terminal and the second connecting terminal which face each other, followed by heating and pressing to electrically connect the first connecting terminal and the second connecting terminal which face each other.

claim 49. (new) A circuit terminal connected structure comprising a first circuit member having a first connecting terminal and a second circuit member having a second connecting terminal, wherein:

said circuit members being disposed in such a way that the first connecting terminal and the second connecting terminal face each other; a circuit-connecting material capable of curing upon radical polymerization being interposed between the first connecting terminal and the second connecting terminal which face each other; the surface of at least one of the first and second connecting terminals being formed of a metal selected from gold, silver, tin and platinum group metals; and the first connecting terminal and the second connecting terminal which face each other being electrically connected.

REMARKS

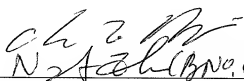
Claims 1, 2, 8, 9, 23-49 are in the case. Claims 3-7 and 10-22 have been canceled without prejudice. New claims 23-49 have been added.

Applicants respectfully request entry of these amendments into the file of the present application prior to the calculation of the filing fee. No fee, in addition to the filing fee, is

believed to be due as a result of this submission. However, should any fee be required, please charge the requisite amount to the Deposit Account No. 16-1150.

Respectfully submitted,

Date: September 30, 1999

By  N2426 (BPN, 0326) 24,576
Charles E. Miller (Reg. No.)

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1155 Avenue of the Americas
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Attorneys for Applicants

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SPECIFICATION

CIRCUIT-CONNECTING MATERIAL AND CIRCUIT TERMINAL
CONNECTED STRUCTURE AND CONNECTING METHOD

TECHNICAL FIELD

5
This invention relates to a circuit-connecting material to be interposed between circuit electrodes facing each other and, the facing electrodes being pressed against each other, to electrically connect the electrodes in the pressing direction. It also relates to a circuit terminal connected structure and a circuit terminal connecting method.

BACKGROUND ART

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Epoxy resin adhesives are widely used for various purposes of electric, electronic, construction, automobile, aircraft and so forth because they can attain a high bonding strength and have excellent water resistance and heat resistance. In particular, one-part epoxy resin adhesives are used in the form of films, pastes or powders because they make it unnecessary to
15 mix the base resin and the curing agent and can be used with ease. In this case, it is general to attain specific performances by using epoxy resins, curing agents and modifiers in various combinations (e.g.,

Japanese Patent Application Laid-open (KOKAI) No.
62-141083).

However, film type epoxy resin adhesives as
disclosed in the above Japanese Patent Application
5 Laid-open (KOKAI) No. 62-141083, though having an
excellent operability, have been required to be heated
at about 140 to 180°C when connected in a time of about
20 seconds, and at about 180 to 210°C when connected in
10 seconds.

10 This is because catalyst type curing agents,
which are inert at normal temperature, are used so that
both short-time curability (rapid curability) and
storage stability (storability) can be achieved to
attain a better stability, and hence no sufficient
15 reaction can take place when cured.

In recent years, in the field of precision
electronic equipment, circuits are being made higher in
density, resulting in very small width of electrodes
and very narrow spaces between electrodes. Hence, there
20 has been a problem that the wiring comes off, separates
or positionally deviates under connecting conditions
for circuit-connecting materials making use of
conventional epoxy resin adhesives. Also, in order to
improve production efficiency, it is increasingly
25 sought to shorten the connecting time to 10 seconds or
less, making it indispensable to attain low-temperature

rapid curability.

DISCLOSURE OF THE INVENTION

The present invention provides an electric and electronic circuit-connecting material having a superior low-temperature rapid curability and also
5 having a long pot life.

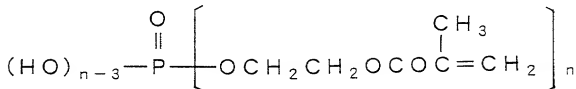
A first circuit-connecting material of the present invention is a circuit-connecting material which is interposed between circuit electrodes facing each other and electrically connects the electrodes in
10 the pressing direction by pressing the facing electrodes against each other;

the circuit-connecting material comprising as essential components the following components (1) to (3):

- 15 (1) a curing agent capable of generating free radicals upon heating;
- (2) a hydroxyl-group-containing resin having a molecular weight of 10,000 or more; and
- (3) a radical-polymerizable substance.

20 As the curing agent capable of generating free radicals upon heating, preferred are curing agents having a 10-hour half-life temperature of 40°C or above and a 1-minute half-life temperature of 180°C or below, and peroxyesters are usable.

The radical-polymerizable substance may contain a radical-polymerizable substance represented by the following chemical formula (a).



... (a)

5 wherein n is an integer of 1 to 3.

As the hydroxyl-group-containing resin having a molecular weight of 10,000 or more, preferred are phenoxy resins, in particular, phenoxy resins modified with a carboxyl-group-containing elastomer and phenoxy
10 resins modified with an epoxy-group-containing elastomer.

A second circuit-connecting material of the present invention is a circuit-connecting material which is interposed between circuit electrodes facing
15 each other and electrically connects the electrodes in the pressing direction by pressing the facing electrodes against each other;

the circuit-connecting material comprising as essential components the following components (3) and
20 (4):

(3) a curing agent capable of generating free radicals upon heating and having a 10-hour half-life

temperature of 40°C or above and a 1-minute half-life
temperature of 180°C or below; and

(4) a radical-polymerizable substance.

As the curing agent capable of generating free
5 radicals upon heating, peroxyesters are preferred.

The circuit-connecting material described above
may contain an acrylic rubber.

A third circuit-connecting material of the
present invention is a circuit-connecting material
10 which is interposed between circuit electrodes facing
each other and electrically connects the electrodes in
the pressing direction by pressing the facing
electrodes against each other;

the circuit-connecting material having, in the
15 measurement with a differential scanning calorimeter
(DSC) at 10°C/min., an exothermic reaction arising
temperature (Ta) within a range of from 70°C to 110°C, a
peak temperature (Tp) of Ta + 5 to 30°C and an end
temperature (Te) of 160°C or below.

20 The above circuit-connecting material may
contain conductive particles.

The circuit terminal connected structure of the
present invention comprises a first circuit member
having a first connecting terminal and a second circuit
25 member having a second connecting terminal;

the circuit members being disposed in such a way

that the first connecting terminal and the second
connecting terminal face each other; the
circuit-connecting material described above being
interposed between the first connecting terminal and
5 the second connecting terminal which face each other;
and the first connecting terminal and the second
connecting terminal which face each other being
electrically connected.

The circuit terminal connecting method of the
10 present invention comprises;

disposing a first circuit member having a first
connecting terminal and a second circuit member having
a second connecting terminal, in such a way that the
first connecting terminal and the second connecting
15 terminal face each other and interposing the
circuit-connecting material described above, between
the first connecting terminal and the second connecting
terminal which face each other, followed by heating and
pressing to electrically connect the first connecting
20 terminal and the second connecting terminal which face
each other.

The circuit terminal connected structure of the
present invention may also comprise a first circuit
member having a first connecting terminal and a second
25 circuit member having a second connecting terminal;

the circuit members being disposed in such a way

that the first connecting terminal and the second
connecting terminal face each other; a
circuit-connecting material capable of curing upon
radical polymerization being interposed between the
5 first connecting terminal and the second connecting
terminal which face each other; the surface of at least
one of the first and second connecting terminals being
formed of a metal selected from gold, silver, tin and
platinum group metals; and the first connecting
10 terminal and the second connecting terminal which face
each other being electrically connected.

The circuit terminal connecting method of the
present invention may also comprise;

disposing a first circuit member having a first
15 connecting terminal and a second circuit member having
a second connecting terminal, in such a way that the
first connecting terminal and the second connecting
terminal face each other and interposing a
circuit-connecting material capable of curing upon
20 radical polymerization, between the first connecting
terminal and the second connecting terminal which face
each other, followed by heating and pressing to
electrically connect the first connecting terminal and
the second connecting terminal which face each other;
25 the surface of at least one of the first and
second connecting terminals being formed of a metal

having a 10-hour half-life temperature of 40°C or above
and a 1-minute half-life temperature of 180°C or below
are preferred, and organic peroxides having a 10-hour
half-life temperature of 60°C or above and a 1-minute
5 half-life temperature of 170°C or below are preferred.

The curing agent may preferably be mixed in an
amount of from 0.05 to 10 parts by weight, and more
preferably from 0.1 to 5 parts by weight, based on 100
parts by weight of the total weight of the
10 hydroxyl-group-containing resin having a molecular
weight of 10,000 or more and radical-polymerizable
substance.

The curing agent may be selected from diacyl
peroxides, peroxydicarbonates, peroxyesters,
15 peroxyketals, dialkyl peroxides, hydroperoxides and
silyl peroxides. In order to keep connecting terminals
of the circuit member from corrosion, chloride ions or
organic acids contained in the curing agent may
preferably be in an amount of 5,000 ppm or less. Curing
20 agents that may generate less organic acids after
heating and decomposition are more preferred.

Stated specifically, the curing agent may
preferably be selected from peroxyesters, dialkyl
peroxides, hydroperoxides and silyl peroxide, and may
25 more preferably be selected from peroxyesters with
which high reactivity can be obtained.

These curing agents may be used in an appropriate combination.

As the peroxyesters, usable are cumyl peroxyneodecanoate, 1,1,3,3-tetramethylbutyl peroxyneodecanoate, 1-cyclohexyl-1-methylethyl peroxyneodecanoate, t-hexyl peroxyneodecanoate, t-butyl peroxy-pivalate, 1,1,3,3-tetramethylbutyl peroxy-2-ethylhexanoate, 2,5-dimethyl-2,5-di(2-ethylhexanoylperoxy)hexane, 1-cyclohexyl-1-methylethyl peroxy-2-ethylhexanoate, t-hexyl peroxy-2-ethylhexanoate, t-butyl peroxy-2-ethylhexanoate, t-butyl peroxyisobutyrate, 1,1-bis(t-butylperoxy)cyclohexane, t-hexyl peroxyisopropylmonocarbonate, t-butyl peroxy-3,5,5-trimethylhexanoate, t-butyl peroxy-laurate, 2,5-dimethyl-2,5-di(m-toluoylethylperoxy)hexane, t-butyl peroxyisopropylmonocarbonate, t-butyl peroxy-2-ethylhexylmonocarbonate, t-hexyl peroxybenzoate, t-butyl peroxyacetate and the like.

As the dialkyl peroxides, α,α' -bis(t-butylperoxy)diisopropylbenzene, dicumyl peroxide, 2,5-dimethyl-2,5-di(t-butylperoxy)hexane, t-butylcumyl peroxide and the like may be used.

As the hydroperoxides, diisopropylbenzene hydroperoxide, cumene hydroperoxide and the like may be used.

As the diacyl peroxides, isobutyl peroxide,
2,4-dichlorobenzoyl peroxide, 3,5,5-trimethylhexanoyl
peroxide, octanoyl peroxide, lauroyl peroxide, stearoyl
peroxide, succinic peroxide, benzoyl peroxytoluene,
5 benzoyl peroxide and the like may be used.

As the peroxydicarbonates, di-n-propyl
peroxydicarbonate, diisopropyl peroxydicarbonate,
bis(4-t-butylcyclohexyl) peroxydicarbonate,
di-2-ethoxymethoxyperoxydicarbonate,
10 di(2-ethylhexylperoxy)dicarbonate, dimethoxybutyl
peroxydicarbonate,
di(3-methyl-3-methoxybutylperoxy)dicarbonate and the
like may be used.

As the peroxyketals,
15 1,1-bis(t-hexylperoxy)-3,3,5-trimethylcyclohexane,
1,1-bis(t-hexylperoxy)cyclohexane,
1,1-bis(t-butylperoxy)-3,3,5-trimethylcyclohexane,
1,1-(t-butylperoxy)cyclododecane,
2,2-bis(t-butylperoxy)decane and the like may be used.

As the silyl peroxides, t-butyltrimethylsilyl
peroxide, bis(t-butyl)dimethylsilyl peroxide,
t-butyltrivinylsilyl peroxide, bis(t-butyl)divinylsilyl
peroxide, tris(t-butyl)vinylsilyl peroxide,
t-butyltriallylsilyl peroxide, bis(t-butyl)diallylsilyl
25 peroxide, tris(t-butyl)allylsilyl peroxide and the like
may be used.

Any of these curing agents capable of generating free radicals may be used alone or in combination, and a decomposition accelerator or inhibitor may be used in combination.

These curing agents may also be coated with a polymeric substance of polyurethane type or polyester type so as to be made into microcapsules. Such curing agents are preferred because their pot life can be made longer.

The radical-polymerizable substance used in the present invention is a substance having a functional group capable of undergoing radical polymerization, and may include acrylates, methacrylates, maleimide compounds and the like. The radical-polymerizable substance may be used in the state of either of a monomer and an oligomer. Such monomer and oligomer may also be used in combination.

As specific examples of the acrylates (methacrylates inclusive), they include methyl acrylate, ethyl acrylate, isopropyl acrylate, isobutyl acrylate, ethylene glycol diacrylate, diethylene glycol diacrylate, trimethylolpropane triacrylate, tetramethylolmethane tetraacrylate, 2-hydroxy-1,3-diacryloxypropane, 2,2-bis[4-(acryloxymethoxy)phenyl]propane, 2,2-bis[4-(acryloxypolyethoxy)phenyl]propane,

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dicyclopentenyl acrylate, tricyclodecanyl acrylate, tris(acryloyloxyethyl) isocyanurate and the like. Any of these may be used alone or in combination. If necessary, a polymerization inhibitor such as

5 hydroquinones and methyl ether hydroquinones may appropriately be used. Also, an instance where the radical-polymerizable substance has a dicyclopentenyl group and/or a tricyclodecanyl group and/or a triazine ring is preferred because heat resistance is improved.

10 The maleimide compounds may include those having at least two maleimide groups in the molecule, as exemplified by 1-methyl-2,4-bismaleimide benzene, N,N'-m-phenylenebismaleimide, N,N'-p-phenylenebismaleimide,

15 N,N'-m-toluylenebismaleimide, N,N'-4,4-biphenylenebismaleimide, N,N'-4,4-(3,3'-dimethyl-biphenylene)bismaleimide, N,N'-4,4-(3,3'-dimethyldiphenylmethane)bismaleimide, N,N'-4,4-(3,3'-diethyldiphenylmethane)bismaleimide,

20 N,N'-4,4-diphenylmethanebismaleimide, N,N'-4,4-diphenylpropanebismaleimide, N,N'-4,4-diphenyl ether bismaleimide, N,N'-3,3'-diphenyl sulfone bismaleimide,

2,2-bis[4-(4-maleimidophenoxy)phenyl]propane,

25 2,2-bis[3-s-butyl-4-8(4-maleimidophenoxy)phenyl]propane, 1,1-bis[4-(4-maleimidophenoxy)phenyl]decane,

4,4'-cyclohexylidene-bis[1-(4-maleimidophenoxy)-2-cyclohexylbenzene and

2,2-bis[4-(4-maleimidophenoxy)phenyl]hexafluoropropane.

Any of these may be used alone or in combination.

5 Use of the above radical-polymerizable substance in combination with a radical-polymerizable substance having the phosphate structure represented by the above chemical formula (a) brings about an improvement in bonding strength on the surface of an inorganic matter
10 such as metal. The radical-polymerizable substance may preferably be mixed in an amount of from 0.1 to 10 parts by weight, and more preferably from 0.5 to 5 parts by weight, based on 100 parts by weight of the total weight of the hydroxyl-group-containing resin
15 having a molecular weight of 10,000 or more and radical-polymerizable substance.

 The radical-polymerizable substance having the phosphate structure can be obtained as a reaction product of phosphoric anhydride with 2-hydroxyethyl
20 acrylate or methacrylate. Stated specifically, it may include mono(2-methacryloyloxyethyl) acid phosphate and di(2-methacryloyloxyethyl) acid phosphate or the like. Any of these may be used alone or in combination.

 As the hydroxyl-group-containing resin having a
25 molecular weight of 10,000 or more, polymers such as polyvinyl butyral, polyvinyl formal, polyamide,

polyester, phenol resin, epoxy resin and phenoxy resin may be used, which exhibit superior stress relaxation properties at the time of curing and bring about an improvement in adhesion attributable to hydroxyl groups.

- 5 Those obtained by modifying any of these polymers with radical-polymerizable functional groups are more preferred because heat resistance is improved. In such an instance, they are hydroxyl-group-containing resins having a molecular weight of 10,000 or more and also
- 10 radical-polymerizable substances.

These polymers may preferably have a molecular weight of 10,000 or more, but those having a molecular weight of 1,000,000 or more tend to have poor mixing properties.

- 15 As the hydroxyl-group-containing resin having a molecular weight of 10,000 or more, a hydroxyl-group-containing resin having a T_g (glass transition temperature) of 40°C or above and having a molecular weight of 10,000 or more may be used, and
- 20 phenoxy resin may be used. The hydroxyl-group-containing resin having a molecular weight of 10,000 or more may be modified with a carboxyl-group-containing elastomer, an epoxy-group-containing elastomer or a
- 25 radical-polymerizable functional group. Those modified with the radical-polymerizable functional group are

preferred because heat resistance is improved.

The phenoxy resin is a resin obtained by allowing a bifunctional phenol to react with an epihalohydrin to have a high molecular weight, or
5 subjecting a bifunctional epoxy resin and a bifunctional phenol to polyaddition reaction. Stated specifically, it can be obtained by allowing 1 mole of a bifunctional phenol to react with 0.985 to 1.015 mole of an epihalohydrin in the presence of an alkali metal
10 hydroxide, in a non-reactive solvent and at a temperature of from 40 to 120°C.

In view of mechanical properties and thermal properties of the resin, particularly preferred is a resin obtained using a bifunctional epoxy resin and a
15 bifunctional phenol which are mixed in an equivalent weight ratio of epoxy group/phenolic hydroxyl group = 1/0.9 to 1/1.1, and by subjecting them to polyaddition reaction in the presence of a catalyst such as an alkali metal compound, an organic phosphorus compound
20 or a cyclic amine compound, in an organic solvent having a boiling point of 120°C or above of such as amides, ethers, ketones, lactones or alcohols, and at a reaction solid matter concentration of 50% by weight or less while heating the system to 50 to 200°C.

25 The bifunctional epoxy resin may include bisphenol-A epoxy resin, bisphenol-F epoxy resin,

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bisphenol-AD epoxy resin, bisphenol-S epoxy resin, and
alkylene oxide addition products, halides (such as
tetrabromophenol epoxy resin) or hydrogenation products
of these, as well as alicyclic epoxy resins, aliphatic
5 chain epoxy resins and halides or hydrogenation
products of these.

These compounds may have any molecular weight.
Especially when reacted with the bifunctional phenol,
those having a purity as high as possible are preferred.
10 These compounds may be used in combination of some
kinds.

The epihalohydrin may include epichlorohydrin,
epibromohydrin and epiiodohydrin.

The bifunctional phenol may be any phenols so
15 long as they are compounds having two phenolic hydroxyl
groups, as exemplified by monocyclic bifunctional
phenols such as hydroquinone, 2-bromohydroquinone,
resorcinol and catechol, bisphenols such as bisphenol A,
bisphenol F, bisphenol AD and bisphenol S,
20 dihydroxybiphenyls such as 4,4'-dihydroxybiphenyl,
dihydroxyphenyl ethers such as bis(4-hydroxyphenyl)
ether, and any of these compounds into the aromatic
ring of the phenolic skeleton of which a straight-chain
alkyl group, a branched alkyl group, an aryl group, a
25 methylol group, an allyl group, a cyclic aliphatic
group, a halogen atom (to form, e.g.,

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tetrabromobisphenol A), a nitro group or the like has been introduced, and also polycyclic bifunctional phenols formed by introducing a straight-chain alkyl group, a branched alkyl group, an allyl group, an allyl group with a substituent, a cyclic aliphatic group or an alkoxy carbonyl group into the carbon atom present at the center of the bisphenolic skeleton of any of these compounds.

Stated specifically, the bifunctional phenol may include 4,4'-(1-methylethylidene)bis[2-methylphenol], 4,4'-methylenebis[2-methylphenol], 4,4'-(1-methylethylidene)bis[2-(1-methylethyl)phenol], 4,4'-(1-methylethylidene)bis[2-(1,1-methylpropyl)phenol], 4,4'-(1-methylethylidene)bis[2-(1,1-dimethylethyl)phenol], tetramethylbisphenol A, tetramethylbisphenol F, 4,4'-methylenebis[2,6-bis(1,1-dimethylethyl)phenol], 4,4'-(1-methylethylidene)bis[2,6-di(1,1-dimethylethyl)phenol], 4,4'-(1-methylethylidene)bis[2-(2-propenyl)phenol], 4,4'-methylenebis[2-(2-propenyl)phenol], 4,4'-(1-methylethylidene)bis[2-(1-phenylethyl)phenol], 3,3'-dimethyl[1,1'-biphenyl]-4,4'-diol, 3,3',5,5'-tetramethyl[1,1'-biphenyl]-4,4'-diol, 3,3',5,5'-tetra-t-butyl[1,1'-biphenyl]-4,4'-diol, 3,3'-bis(2-propenyl)-[1,1'-biphenyl]-4,4'-diol,

- 4,4'-(1-methylethylidene)bis[2-methyl-6-hydroxymethylphenol], tetramethylolbisphenol A,
 3,3',5,5'-tetrakis(hydroxymethyl)-(1,1'-biphenyl)-4,4'-diol, 4,4'-(1-methylethylidene)bis[2-phenylphenol],
 4,4'-(1-methylethylidene)bis[2-cyclohexylphenol],
 4,4'-methylenebis(2-cyclohexyl-5-methylphenol),
 4,4'-(1-methylpropylidene)bisphenol,
 4,4'-(1-methylheptylidene)bisphenol,
 4,4'-(1-methyloctylidene)bisphenol,
 4,4'-(1,3-dimethylbutylidene)bisphenol,
 4,4'-(2-ethylhexylidene)bisphenol,
 4,4'-(2-methylpropylidene)bisphenol,
 4,4'-propylidenebisphenol,
 4,4'-(1-ethylpropylidene)bisphenol,
 4,4'-(3-methylbutylidene)bisphenol,
 4,4'-(1-phenylethylidene)bisphenol,
 4,4'-(phenylmethylene)bisphenol,
 4,4'-(diphenylmethylene)bisphenol,
 4,4'-[1-(4-nitrophenyl)ethylidene]bisphenol,
 4,4'-[1-(4-aminophenyl)ethylidene]bisphenol,
 4,4'-(4-bromophenyl)methylenebisphenol,
 4,4'-(4-chlorophenyl)methylenebisphenol,
 4,4'-(4-fluorophenyl)methylenebisphenol,
 4,4'-(2-methylpropylidene)bis[3-methyl-6-(1,1-dimethyl-
 thyl)phenol],
 4,4'-(1-ethylpropylidene)bis[2-methylphenol],

4,4'-(1-phenylethylidene)bis[2-methylphenol],
4,4'-(phenylmethylene)bis-2,3,5-trimethylphenol,
4,4'-(phenylethylidene)bis[2-(1,1-dimethylethyl)phenol]

5 4,4'-(1-methylpropylidene)bis[2-cyclohexyl-5-methylphenol], 4,4'-(1-phenylethylidene)bis[2-phenylphenol],
4,4'-butylidenebis[3-methyl-6-(1,1-dimethylethyl)phenol], 4-hydroxy- α -(4-hydroxyphenyl)- α -methylbenzene acetic acid methyl ester,

10 4-hydroxy- α -(4-hydroxyphenyl)- α -methylbenzene acetic acid ethyl ester, 4-hydroxy- α -(4-hydroxyphenyl)benzene acetic acid butyl ester, tetrabromobisphenol A, tetrabromobisphenol F, tetrabromobisphenol AD,
4,4'-(1-methylethylene)bis[2,6-dichlorophenol],
15 4,4'-(1-methylethylidene)bis[2-chlorophenol],
4,4'-(1-methylethylidene)bis[2-chloro-6-methylphenol],
4,4'-methylenebis[2-fluorophenol],
4,4'-methylenebis[2,6-difluorophenol],
4,4'-isopropylidenebis[2-fluorophenol],
20 3,3'-difluoro-[1,1'-diphenyl]-4,4'-diol,
3,3',5,5'-tetrafluoro-[1,1'-biphenyl]-4,4'-diol,
4,4'-(phenylmethylene)bis[2-fluorophenol],
4,4'-(4-fluorophenyl)methylenebis[2-fluorophenol],
4,4'-(phenylmethylene)bis[2,6-difluorophenol],
25 4,4'-(4-fluorophenyl)methylenebis[2,6-difluorophenol],
4,4'-(diphenylmethylene)bis[2-fluorophenol],
4,4'-(diphenylmethylene)bis[2,6-difluorophenol],

4,4'-(1-methylethylene)bis[2-nitrophenol] and the like.

- The polycyclic bifunctional phenols other than these may include 1,4-naphthalene diol, 1,5-naphthalene diol, 1,6-naphthalene diol, 1,7-naphthalene diol,
- 2,7-naphthalene diol, 4,4'-dihydroxydiphenyl ether, bis(4-hydroxyphenyl) methanone,
- 4,4'-cyclohexylidenebisphenol,
- 4,4'-cyclohexylidenebis[2-methylphenol],
- 4,4'-cyclopentylidenebisphenol,
- 4,4'-cyclopentylidenebis[2-methylphenol],
- 4,4'-cyclohexylidene[2,6-dimethylphenol],
- 4,4'-cyclohexylidenebis[2-(1,1-dimethylethyl)phenol],
- 4,4'-cyclohexylidenebis[2-cyclohexylphenol],
- 4,4'-(1,2-ethanediyl)bisphenol,
- 4,4'-cyclohexylidenebis[2-phenylphenol],
- 4,4'-[1,4-phenylenebis(1-methylethylidene)]bis[2-methylphenol],
- 4,4'-[1,3-phenylenebis(1-methylethylidene)]bisphenol,
- 4,4'-[1,4-phenylenebis(1-methylethylidene)]bisphenol,
- 4,4'-[1,4-phenylenebis(1-methylethylidene)]bis[2-methyl-6-hydroxymethylphenol],
- 4-{1-[4-(4-hydroxy-3-methylphenyl)-4-methylcyclohexyl]-1-methylethyl}-2-methylphenol,
- 4-{1-[4-(4-hydroxy-3,5-dimethylphenyl)-4-methylcyclohexyl]-1-methylethyl}-2,6-dimethylphenol,
- 4,4'-(1,2-ethanediyl)bis[2,6-di-(1,1-dimethylethyl)phen

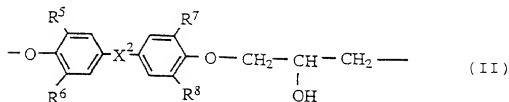
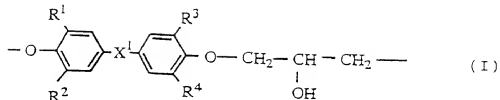
ol], 4,4'-(dimethylsilylene)bisphenol,
1,3-bis(p-hydroxyphenyl)-1,1,3,3-tetramethyldisiloxane,
silicone oligomers both-end terminated with
p-hydroxyphenyl groups, and 2,2'-methylidenebisphenol,
2,2'-methylethylidenebisphenol,
2,2'-ethylidenebisphenol or the like into the aromatic
ring of the phenolic skeleton of which a straight-chain
alkyl group, a branched alkyl group, an aryl group, a
methylol group or an allyl group has been introduced.

10 Stated specifically, the last-mentioned ones may
include 2,2'-methylidenebis[4-methylphenol],
2,2'-ethylidenebis[4-methylphenol],
2,2'-methylidenebis[4,6-dimethylphenol],
2,2'-(1-methylethylidene)bis[4,6-dimethylphenol],
15 2,2'-(1-methylethylidene)bis[4-sec-butylphenol],
2,2'-methylidenebis[6-(1,1-dimethylethyl)-4-methylpheno
l], 2,2'-ethylidenebis[4,6-di(1,1-dimethylethyl)phenol],
2,2'-methylidenebis[4-nonylphenol],
2,2'-methylidenebis[3-methyl-4,6-di(1,1-dimethylethyl)p
20 henol],
2,2'-(2-methylpropylidene)]bis[2,4-dimethylphenol],
2,2'-ethylidenebis[4-(1,1-dimethylethyl)phenol],
2,2'-methylidenebis(2,4-di-t-butyl-5-methylphenol),
2,2'-methylidenebis(4-phenylphenol),
25 2,2'-methylidenebis(4-methyl-6-hydroxymethylphenol),
2,2'-methylenebis[6-(2-propenyl)phenol] and the like.

These compounds may be used in combination of some kinds.

Solution formed after the reaction is completed may be purified by reprecipitation using a bad solvent
5 such as methanol to obtain the product as a solid phenoxy resin. The phenoxy resin thus produced may be used in combination of two or more.

To achieve the object of the present invention, the phenoxy resin may preferably be a resin comprised
10 of a first constituent unit represented by the following Formula (I) and/or a second constituent unit represented by the following Formula (II) and containing at least one first constituent unit in the molecule. In a case where a copolymer having both the
15 first constituent unit and the second constituent unit is used as the phenoxy resin, the phenoxy resin may preferably contain at least 10 mole% of the first constituent unit, and may more preferably in a copolymerization ratio of first constituent unit :
20 second constituent unit = 2:8 to 8:2. In a case where two or more types of phenoxy resins are used, at least one of them may preferably be comprised of the first constituent unit and/or the second constituent unit and contain at least one first constituent unit in the
25 molecule.

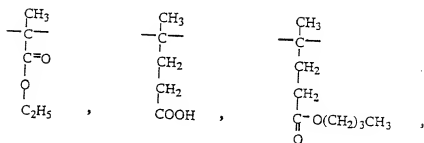
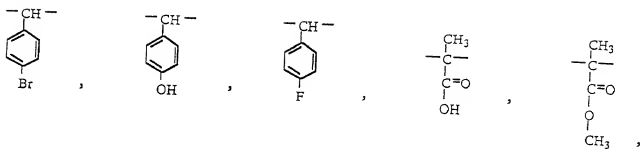
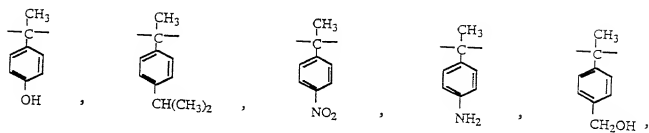
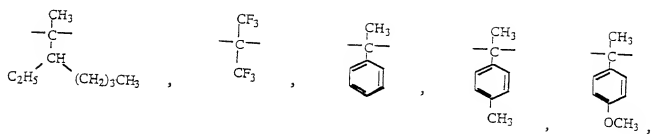
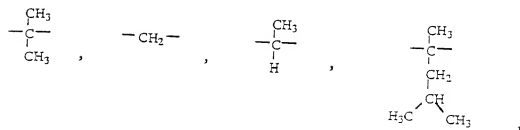


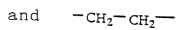
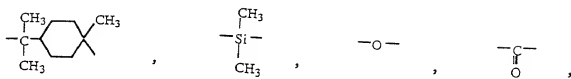
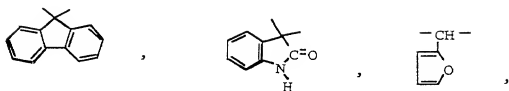
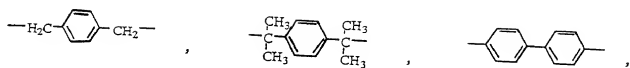
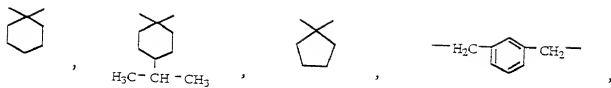
In the formulae, R¹ to R⁴ are each independently selected from a hydrogen atom, an alkyl group having 1 to 4 carbon atoms (such as a methyl group, an ethyl group, a propyl group, a butyl group, an isopropyl group or an isobutyl group) and an electron-withdrawing group. At least one of R¹ to R⁴ is an electron-withdrawing group. The electron-withdrawing group refers to a group whose Hammett's substituent constant σ has the positive value ("Chemical Dictionary", pp.833-834, 1986, Morikita Publish. Inc.). It may include, e.g., halogens such as a fluorine atom, a chlorine atom and a bromine atom, a trifluoromethyl group, a trichloromethyl group, a tribromomethyl group, a nitro group, a nitrile group, alkoxyl groups such as a methoxyl group and an ethoxyl group, a carboxyl group, alkylcarbonyl groups such as a methylcarbonyl group and an ethylcarbonyl group, alkoxycarbonyl groups such as a methoxycarbonyl group and an ethoxycarbonyl group, and alkylsulfonyl groups. The halogens are preferred.

R⁵ to R⁸ are each independently selected from a hydrogen atom and an alkyl group having 1 to 4 carbon atoms (such as a methyl group, an ethyl group, a propyl group, a butyl group, an isopropyl group or an isobutyl group).

X¹ and X² each represent a divalent organic group or linkage. There are no particular limitations on the divalent organic group represented by X¹ and X². For example, it may include the following.

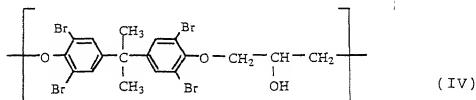
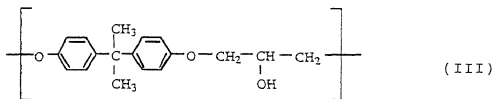
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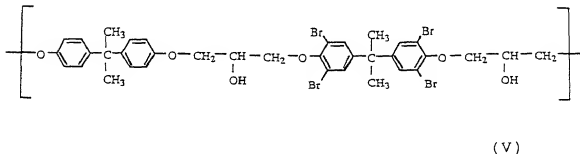


The phenoxy resin as described above can be obtained by using synthesis materials at least one of which is the bifunctional epoxy resin and/or bifunctional phenol which have a hydrogen atom, an alkyl group having 1 to 4 carbon atoms or an electron-withdrawing group.

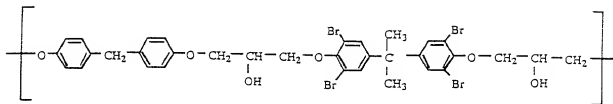
As specific examples of such an phenoxy resin, it may include, e.g., a random copolymer comprised of a repeating unit represented by the following structural formula (III) and a repeating unit represented by the following structural formula (IV):



a polymer comprised of a repeating unit represented by the following structural formula (V):

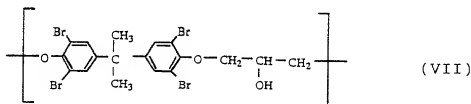


a polymer comprised of a repeating unit represented by the following structural formula (VI):



(VI)

a polymer comprised of a repeating unit represented by
5 the following structural formula (VII):



(VII)

and the like.

In order for cured products to exhibit excellent properties such as flexibility, toughness and
10 film-forming properties, a phenoxy resin is used which preferably has an average molecular weight (weight-average molecular weight in terms of polystyrene as measured by gel permeation chromatography) of at least 10,000, more preferably at
15 least 20,000, and still more preferably at least 30,000. As commercially available products, it may include, e.g., PKHH and PAHJ (available from Union Carbide

Corporation), YPB-43C, YPB-43D, YPB-43G, YPB-43m and YP-50 or YPB-40ASB25 and YPB-40AM40 (available from Tohto Kasei Co., Ltd.), which may be purified by reprecipitation.

5 The carboxyl-group-containing elastomer and the epoxy-group-containing elastomer may be any elastomers so long as they are those having a carboxyl group or epoxy group at the molecular terminal or in the molecular chain, including, e.g., butadiene copolymers,
10 acrylic copolymers, polyether-urethane rubbers, polyester-urethane rubbers, polyamide-urethane rubbers and silicone rubbers. Butadiene type polymers are preferred. Incidentally, the butadiene type polymers may include butadiene polymer, butadiene-styrene
15 copolymer, butadiene-acrylonitrile copolymer and the like. In particular, butadiene-acrylonitrile copolymer is preferred.

 The carboxyl-group-containing elastomer may preferably have a weight-average molecular weight
20 ranging from 500 to 1,000,000, more preferably from 1,000 to 800,000, and still more preferably from 1,000 to 10,000.

 The quantity of a component compatible with the phenoxy resin contained in the elastomer skeleton may
25 preferably be so determined that the phenoxy phase and the elastomer phase may be kept phase-separated,

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because the both may dissolve mutually if such a component is in a large quantity. The quantity of this component can be regulated as desired in accordance with the structure (SP value) of phenoxy resins and the heat resistance and mechanical strength of resins having been modified. For example, in the case of the butadiene-acrylonitrile copolymer, the content of the acrylonitrile may preferably be set to be not more than 40% by weight, more preferably from 5 to 40% by weight, and still more preferably from 10 to 30% by weight. As commercially available products, it may include, e.g., HYCAR CTBN1300x31, HYCAR CTBN1300x8, HYCAR CTBN1300x13, HYCAR CTBNX1300x9, HYCAR CTBNX1009-SP and HYCAR CTB200x162 (available from Ube Industries, Ltd.), NIPOL DN 601 (available from Nippon Zeon Co., Ltd.), Nisso PB C-1000, C-2000 (available from Nippon Soda Co., Ltd.), and ELC-4 (available from Japan Synthetic Rubber Co., Ltd.).

When the sealing molding material of the present invention is used for electronic parts and devices such as semiconductors, ionic impurities in the material may preferably be made as less as possible. Accordingly, in these carboxyl-group-containing elastomers, too, alkali metal ions such as Na^+ and K^+ in the polymer may preferably be not more than 10 ppm, and more preferably not more than 5 ppm, and Cl^- may preferably be not more

than 400 ppm, more preferably not more than 100 ppm,
and still more preferably not more than 40 ppm.

Such a phase-separated structural product of the
present invention can be produced, e.g., in the
5 following way.

First, the phenoxy resin is dissolved in a
solvent, and the carboxyl-group-containing elastomer is
dissolved in the resultant solution (the volume ratio
of the phenoxy resin and the elastomer may be set as
10 desired in accordance with the target values of
flexibility, toughness and bonding strength of cured
products, required in purposes for which the products
are used, where the ratio of phenoxy resin : elastomer
may preferably be in the range of from 60:40 to 90:10,
15 and more preferably from 66:33 to 87:13).

The solvent used when produced may be any
solvents so long as they are those capable of
dissolving the phenoxy resin and
carboxyl-group-containing elastomer. In an instance
20 where a blocked isocyanate, described later, is added
to the solution formed after heat-mixing, the solvent
must be a solvent inert to isocyanate groups.

Next, the interior of the solution is well
displaced with nitrogen, and thereafter the solution is
25 mixed with stirring while heating it at about 100°C to
about 220°C, and preferably about 130°C to about 180°C,

in an atmosphere of nitrogen until the solution becomes semitransparent or transparent at normal temperature and preferably it comes to have a constant value of viscosity. The heat-mixing may preferably be carried
5 out while refluxing the solvent.

The elastomer-modified phenoxy resin solution thus formed after the heat-mixing is completed may be purified by reprecipitation using a bad solvent such as methanol to obtain the product as a solid
10 phase-separated structural product. The mechanism of such modification is unclear, but it has been ascertained that, in H1-NMR spectra before and after modification, the integral value corresponding to protons of the methine bonded to the hydroxyl group in
15 the phenoxy resin skeleton has decreased after modification. It has also been ascertained that, in FT-IR (Fourier-transform infrared absorption) spectra, remarkable changes have occurred in the spectra in the regions of from 3,460 cm^{-1} to 3,560 cm^{-1} and from 1,610
20 cm^{-1} to 1,640 cm^{-1} which are not seen in products obtained by merely blending elastomers. From these facts, it is presumed that at least part of carboxyl groups of the carboxyl-group-containing elastomer and at least part of hydroxyl groups of the phenoxy resin
25 form an ester linkage.

In the elastomer-modified phenoxy resin which is

obtained in this way, the phenoxy resin and the
carboxyl-group-containing elastomer make up phase
separation, and this phase-separated structural product
alone can form an optically transparent or
5 semitransparent film-like product. Such a film-like
product, when formed in a layer thickness of 75 μm , may
preferably have a light transmittance at 500 nm
wavelength, of 10% or more with respect to the light
transmittance of air. The light transmittance may more
10 preferably be from 20 to 90%, and still more preferably
from 30 to 85%.

Whether or not the phase separation has been
made up can be ascertained by observation with a
scanning or transmission electron microscope or an
15 atomic force microscope or by dynamic viscoelasticity
measurement, light scattering or small-angle X-ray
scattering ("Polymer Blends", pp.80-124, CMC Co. Ltd.).

For example, in the dynamic viscoelasticity
measurement, it may be ascertained by the phenomenon
20 that the $\tan\delta$ (loss elastic modulus G'' /storage elastic
modulus G') peak of principal dispersion of the
elastomer phase and the $\tan\delta$ peak of principal
dispersion of the phenoxy resin phase are present
independently.

25 The phase-separated structural product of the
present invention may preferably have a microscopic

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phase-separated structure wherein, in a scanning electron microscope of the film-like product, the elastomer phase and the phenoxy resin phase are dispersed in the form of very small particles of

5 submicroscopic order of about 0.1 to 0.3 μm . Such a film-like product of phase-separated structure stands optically transparent or semitransparent. More specifically, the light transmittance of the phase-separated structural product of the present

10 invention, when formed in the film-like product with a layer thickness of 75 μm , is 10% or more with respect to the light transmittance of air.

The phase-separated structure of the elastomer-modified phenoxy resin obtained in the

15 present invention may include, e.g., the microscopic phase-separated structure formed of the elastomer phase and phenoxy resin phase, and a microscopic phase-separated structure formed of microscopic domains connected with one another, which are structures

20 hitherto unknown in the mixing of carboxyl-group-containing elastomers with phenoxy resins. Such a microscopic phase-separated structure is considered to be one factor that brings about an improvement in bonding strength to adherends.

25 The hydroxyl-group-containing resin having a molecular weight of 10,000 or more and the

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radical-polymerizable substance may preferably be formulated in such amounts of (hydroxyl-group-containing resin having a molecular weight of 10,000 or more/radical-polymerizable substance) of from 10/90 to 90/10, and more preferably from 30/70 to 70/30, in weight ratio.

In the circuit-connecting material of the present invention, a copolymer acrylic rubber which is a polymer or copolymer having as a monomer component at least one of acrylic acid, acrylate, methacrylate and acrylonitrile and contains glycidyl acrylate or glycidyl methacrylate containing a glycidyl ether group may also be used in combination. Such a material brings about superior stress relaxation, and is preferred. The acrylic rubber may preferably have a molecular weight (weight average) of 200,000 or more in view of an improvement of cohesive force of adhesives.

The circuit-connecting material may also contain a filler, a softener, an accelerator, an anti-aging agent, a colorant, a flame retardant, a thixotropic agent, a coupling agent and a phenol resin, as well as a melamine resin, a kind of isocyanates and the like.

The material containing a filler can improve connection reliability and so forth, and is preferred. The filler may be used so long as its maximum particle diameter is smaller than the particle diameter of the

conductive particles, and may preferably be added in an amount ranging from 5 to 60 parts by volume based on 100 parts by volume of the adhesive resin component. Its addition in an amount more than 60 parts by volume
5 may saturate the effect of improving reliability, and, in an amount less than 5 part by volume, may bring about less effect of addition.

As the coupling agent, those containing a vinyl group, an acrylic group, an amino group, an epoxy group
10 or an isocyanate group are preferred in view of an improvement of adhesion.

The circuit-connecting material of the present invention is a connecting material which is interposed between circuit electrodes facing each other and
15 electrically connects the electrodes in the pressing direction by pressing the facing electrodes against each other, wherein it has, in measurement with a differential scanning calorimeter (DSC) at 10°C/min., an exothermic reaction arising temperature (Ta) within a
20 range of from 70°C to 110°C, a peak temperature (Tp) of Ta + 5 to 30°C and an end temperature (Te) of 160°C or below.

Conventional epoxy resin film-like adhesives, though having an excellent operability, have been
25 required to be heated at about 140 to 180°C when connected in a time of about 20 seconds, and at about

180 to 210°C when connected in 10 seconds. This is because catalyst type curing agents, which are inert at normal temperature, are used so that both short-time curability (rapid curability) and storage stability
5 (storability) can be achieved to attain a better stability, and hence no sufficient reaction can take place when cured. In recent years, in the field of precision electronic equipment, circuits are being made higher in density, resulting in very small width of
10 electrodes and very narrow spaces between electrodes. Hence, there has been a problem that the wiring comes off, separates or positionally deviates under connecting conditions for circuit-connecting materials making use of conventional epoxy resin adhesives. Also,
15 in order to improve production efficiency, it is increasingly sought to shorten the connecting time to 10 seconds or less, making it indispensable to attain low-temperature rapid curability.

The circuit-connecting material of the present
20 invention can provide an electric and electronic circuit-connecting material which can cure upon heating at 140 to 180°C for about 10 seconds to connect circuit electrodes, and also has a relatively long pot life at room temperature.

25 The circuit-connecting material of the present invention, even when it does not contain any conductive

particles, can achieve connection by bringing the facing circuit electrodes into direct contact when connected, but stabler connection can be achieved in a case where it contains conductive particles.

5 The conductive particles may include particles of metals such as Au, Ag, Ni, Cu and solder or carbon. In order to attain a sufficient pot life, they may preferably have surface layers formed of not a transition metal such as Ni or Cu but a noble metal
10 such as Au, Ag or a platinum group metal, and more preferably be formed of Au. Particles comprising a transition metal such as Ni and surface-coated with a noble metal such as Au may also be used. In a case of particles comprising non-conductive, glass or ceramic
15 or plastic and on which the above conductive layers have been formed by coating to provide outermost layers of a noble metal and cores of plastic, or in a case of heat-fusion metal particles, the particles are deformable upon heating and pressing and hence can have
20 a larger area of contact with electrodes at the time of connection, bringing about an improvement in reliability. Thus, such particles are preferred. Such coat layers of a noble metal may preferably be in a thickness of 100 Å or larger in order to attain a good
25 resistance. However, in a case where layers of a noble metal are provided on particles of a transition metal

such as Ni, it may preferably be in a thickness of 300
Å or larger, since free radicals generated by the redox
action caused when, e.g., the noble-metal layers come
off during the mixing and dispersion of conductive
5 particles may cause a lowering of storage stability.
The conductive particles are used properly in
accordance with purposes, within the range of from 0.1
to 30 parts by volume based on 100 parts by volume of
the adhesive resin component. In order to prevent
10 adjoining circuits from short-circuiting because of any
excess conductive particles, the conductive particles
may more preferably be used within the range of from
0.1 to 10 parts by volume.

The circuit-connecting material may also be
15 separated into two or more layers, and separated into a
layer containing the curing agent capable of generating
free radicals upon heating and a layer containing the
conductive particles. In such an instance, it can be
improved in pot life.

20 The circuit-connecting material of the present
invention may also be used as a film-like adhesive for
bonding IC chips to a chip-mounting substrate or for
bonding electric circuits mutually.

The circuit-connecting material of the present
25 invention may still also be used when semiconductor
chips are bonded and fastened to a substrate with an

adhesive film by face-down bonding and at the same time electrodes of the both are electrically connected to one another.

More specifically, a first circuit member having
5 first connecting terminals and a second circuit member having second connecting terminals may be disposed in such a way that the first connecting terminals and the second connecting terminals face each other, and the circuit-connecting material (film-like adhesive) of the
10 present invention may be interposed between the first connecting terminals and the second connecting terminals which face each other, followed by heating and pressing to electrically connect the first connecting terminals and the second connecting
15 terminals which face each other.

As such circuit members, chip component parts such as semiconductor chips, resistor chips and capacitor chips and substrates such as printed-wiring substrates are used.

20 Usually, in these circuit members, a large number of connecting terminals (which may be in a singular number as occasion calls) are provided. At least one set of the circuit members are disposed in such a way that at least part of the connecting
25 terminals provided on these circuit members face each other, and the adhesive is interposed between the

connecting terminals facing each other, followed by heating and pressing to electrically connect the connecting terminals facing each other.

At least one set of the circuit members is heated and pressed, whereby the connecting terminals facing each other can electrically be connected in direct contact or via conductive particles of an anisotropic conductive adhesive.

In the circuit-connecting material of the present invention, the adhesive melt-flows at the time of connection and, after the circuit electrodes facing each other have been connected, cures to keep the connection, thus the fluidity of the adhesive is an important factor. Using glass sheets of 0.7 mm thick and 15 mm × 15 mm in size and when a circuit-connecting material of 35 μm thick and 5 mm × 5 mm in size is held between the glass sheets and these are heated and pressed at 150°C and 2 MPa for 10 seconds, the value of fluidity (B)/(A) expressed on the basis of an initial area (A) and an area (B) after heating and pressing may preferably be from 1.3 to 3.0, and more preferably from 1.5 to 2.5. If the value is less than 1.3, the fluidity may be so poor as to enable no good connection in some cases. If it is more than 3.0, air bubbles tend to occur to make reliability poor in some cases.

The circuit-connecting material of the present

invention may preferably have a modulus of elasticity of from 100 to 2,000 MPa, and more preferably from 1,000 to 1,800 MPa, at 40°C after curing.

The circuit terminal connecting method of the present invention is characterized in that the circuit-connecting material capable of curing upon radical polymerization is formed on one circuit electrode whose surface is formed of a metal selected from gold, silver, tin and platinum group metals, and thereafter the other circuit electrode is registered, followed by heating and pressing to connect them.

The circuit electrode connected structure of the present invention is a circuit electrode connected structure wherein circuit electrodes facing each other is electrically connected via a circuit-connecting material, and is characterized in that the surface of at least one of the facing connecting terminals is formed of a metal selected from gold, silver, tin and platinum group metals and the circuit-connecting material is a circuit-connecting material capable of curing upon radical polymerization.

As the circuit-connecting material capable of curing upon radical polymerization, an anisotropic conductive adhesive containing conductive particles may be used. As the conductive particles of such an anisotropic conductive adhesive, conductive particles

are used whose surfaces are formed of a noble metal selected from gold, silver and platinum group metals.

As a result of extensive studies on connecting methods of electrically connecting circuit electrodes facing each other by the use of adhesives capable of curing upon radical polymerization, good electrical connection can be attained when the surface of at least one of the facing connecting terminals is formed of gold, silver, a platinum group metal or tin, and a radical-polymerizable adhesive is laid and formed on that surface (provisional connection), followed by main connection.

Fig. 1 is a cross-sectional view showing the step of provisional connection of circuit substrates, illustrating an embodiment of the present invention. Fig. 2 is a cross-sectional view showing the step of main connection of circuit substrates, illustrating an embodiment of the present invention. In these figures, reference numerals 1 and 2 denote substrates; 1-a and 2-a, circuit electrodes; 3, an adhesive; 4, conductive particles; and 5, a hot plate.

The substrate 1 used in the present invention is an insulating substrate made of silicone or gallium arsenic as in semiconductor chips, or glass, ceramic, a glass-epoxy composite or plastic, and the substrate 2 facing this substrate is also made of the similar

material.

The circuit electrodes 1-a are provided on the surface of the substrate 1, using copper foil, and gold surface layers are formed thereon. The surface layers
5 are formed of gold, silver, a platinum group metal or tin, any of which may be selected and any of which may be used in combination. Also, a plurality of metals may be combined in the manner of, e.g., copper/nickel/gold to provide multi-layer configuration. The circuit
10 electrodes 2-a are provided on the surface of the substrate 2, using copper foil, and tin surface layers are formed thereon.

The substrates provided with the circuit electrodes may preferably previously be subjected to
15 heat treatment before the step of connection carried out using the circuit-connecting material in order to eliminate the influence of the volatile component due to heating at the time of connection. The heat treatment may preferably be made under conditions of a
20 temperature of 50°C or above for 1 hour or longer, and more preferably a temperature of 100°C or above for 5 hours or longer.

The adhesive 3 is an adhesive comprised essentially of the curing agent capable of generating
25 free radicals upon heating and the radical-curable substance, or may be the radical-curable anisotropic

conductive adhesive having conductive particles dispersed therein in a prescribed quantity. In the latter, the conductive particles may preferably have surfaces formed of a noble metal selected from gold, silver or a platinum group metal. The adhesive 3 is laid and formed (provisional connection) on the substrate 1.

As shown in Fig. 2, after the provisional connection, the circuit electrodes 1-a of the substrate 1 and the circuit electrodes 2-a of the substrate 2 are registered, and heat and pressure are applied from the upper part of the substrate 2 by means of the hot plate 5 for a prescribed time to complete the main connection.

When circuit electrodes are connected using a radical-curable adhesive having a good reactivity and using circuit electrodes whose surfaces are formed of transition metal such as nickel or copper, radical polymerization inevitably proceeds because of redox action after the radical-curable adhesive is laid and formed (provisional connection) on the circuit electrodes and thereafter left for a certain period of time, so that the adhesive may flow with difficulty to enable no sufficient electrical connection at the time of main connection. However, the present invention enables electric and electronic circuit connection promising a low-temperature curability superior to, and

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a longer pot life than, those of conventional epoxy resin types.

At least one of the substrates provided with the circuit electrodes may be subjected to heat treatment
5 at a temperature of 50°C or above for 1 hour or longer.

Example 1

50 g of phenoxy resin (available from Union Carbide Corp.; trade name: PKHC; average molecular weight: 45,000) was dissolved in a 50/50 (weight ratio)
10 mixed solvent of toluene (boiling point: 110.6°C; SP value: 8.90) and ethyl acetate (boiling point: 77.1°C; SP value: 9.10) to form a solution with a solid content of 40%.

As the radical-polymerizable substance,
15 trihydroxyethyl glycol dimethacrylate (available from Kyoeisha Chemical Co., Ltd.; trade name: 80MFA) was used.

As the free-radical-generating agent, a 50% by weight DOP solution of t-hexylperoxy-2-ethyl hexanoate
20 (available from Nippon Oil & Fats Co., Ltd.; trade name: PERCURE HO) was used.

On the surfaces of polystyrene-core particles, nickel layers of 0.2 μm thick were provided. On the outsides of the nickel layers formed, gold layers of
25 0.04 μm thick were provided. Thus, conductive particles of 10 μm in average particle diameter were produced.

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trihydroxyethyl glycol dimethacrylate and a phosphate
type acrylate (available from Kyoeisha Chemical Co.,
Ltd.; trade name: P2m) were used as
radical-polymerizable substances and the solid weight
5 ratio of the phenoxy resin/trihydroxyethyl glycol
dimethacrylate/phosphate type acrylate was set to be 50
g/49 g/1 g (Example 2), 30 g/69 g/1 g (Example 3) or 70
g/29 g/1 g (Example 4).

Using these circuit-connecting materials, the
10 circuits were connected in the same manner as in
Example 1.

Example 5

A circuit-connecting material was obtained in
the same manner as in Example 1 except that the amount
15 of the curing agent was changed to 2 g.

Using this circuit-connecting material, the
circuits were connected in the same manner as in
Example 1.

Example 6

20 A circuit-connecting material was obtained in
the same manner as in Example 1 except that the curing
agent was changed to t-butyl peroxy-2-ethylhexanoate
(available from Nippon Oil & Fats Co., Ltd.; trade
name: PERBUTYL O).

25 Using this circuit-connecting material, the
circuits were connected in the same manner as in

Example 1.

Example 7

100 g of phenoxy resin (PKHC) of 45,000 in
average molecular weight was allowed to react with 25 g
5 of a butadiene-acrylonitrile copolymer terminated with
a carboxyl group (HYCAR CTBNX1009-SP, available from
Ube Industries, Ltd.) by a conventional process to
produce a phenoxy resin modified with the
butadiene-acrylonitrile copolymer terminated with
10 carboxyl groups. A circuit-connecting material was
obtained in the same manner as in Example 1 except that
this phenoxy resin was used and the solid weight ratio
of the phenoxy resin/trihydroxyethyl glycol
dimethacrylate/phosphate type acrylate was set to be 60
15 g/39 g/1 g.

Using this circuit-connecting material, the
circuits were connected in the same manner as in
Example 1.

Example 8

20 100 g of phenoxy resin (PKHC) of 45,000 in
average molecular weight was modified with 25 g of an
epoxy-group-containing acrylic copolymer to produce a
modified phenoxy resin. A circuit-connecting material
was obtained in the same manner as in Example 1 except
25 that this phenoxy resin was used and the solid weight
ratio of the phenoxy resin/trihydroxyethyl glycol

dimethacrylate/phosphate type acrylate was set to be 60 g/39 g/1 g.

Using this circuit-connecting material, the circuits were connected in the same manner as in
5 Example 1.

Example 9

A circuit-connecting material was obtained in the same manner as in Example 1 except that an epoxy-group-containing acrylic copolymer (acrylic
10 rubber) was used and the solid weight ratio of the phenoxy resin/acrylic rubber/trihydroxyethyl glycol dimethacrylate, phosphate type acrylate was set to be 40 g/20 g/39 g/1 g.

Using this circuit-connecting material, the
15 circuits were connected in the same manner as in Example 1.

Example 10

100 g of phenoxy resin (PKHC) of 45,000 in average molecular weight was allowed to react with 5 g
20 of a monoisocyanate terminated with an acrylic group, by a conventional process to produce a phenoxy resin modified with acrylic groups. A circuit-connecting material was obtained in the same manner as in Example 1 except that this phenoxy resin was used and the solid
25 weight ratio of the phenoxy resin/trihydroxyethyl glycol dimethacrylate, phosphate type acrylate was set

to be 60 g/39 g/1 g.

Using this circuit-connecting material, the circuits were connected in the same manner as in Example 1.

5 Example 11

 A circuit-connecting material was obtained in the same manner as in Example 1 except that Ni particles having an average particle diameter of 2 μm and surface-coated with Au (coating thickness: 0.08 μm)
10 were used as the conductive particles and mixed in an amount of 0.5 parts by volume.

 Using this circuit-connecting material, the circuits were connected in the same manner as in Example 1.

15 Example 12

 A circuit-connecting material was obtained in the same manner as in Example 1 except that the conductive particles were replaced with those having particle diameter of 5 μm .

20 Using this circuit-connecting material, the circuits were connected in the same manner as in Example 1.

 Example 13

 A circuit-connecting material was obtained in
25 the same manner as in Example 1 except that 2,2-bis(4-(acryloxy·diethoxy)phenyl)propane (available

from Shin-Nakamura Chemical Co., Ltd.; trade name:
A-BPE-4) was used as the radical-polymerizable
substance and the solid weight ratio of the phenoxy
resin/2,2-bis(4-(acryloxy·diethoxy)phenyl)propane,phosp
5 hate type acrylate was set to be 60 g/39 g/1 g.

Using this circuit-connecting material, the
circuits were connected in the same manner as in
Example 1.

Example 14

10 A circuit-connecting material was obtained in
the same manner as in Example 1 except that
dicyclopentenyl acrylate (available from Kyoeisha
Chemical Co., Ltd.; trade name: DCP-A) was used as the
radical-polymerizable substance and the solid weight
15 ratio of the phenoxy resin/ dicyclopentenyl
acrylate,phosphate type acrylate was set to be 60 g/39
g/1 g.

Using this circuit-connecting material, the
circuits were connected in the same manner as in
20 Example 1.

Example 15

A circuit-connecting material was obtained in
the same manner as in Example 1 except that
tris(acryloyloxyethyl) isocyanurate was used as the
25 radical-polymerizable substance and the solid weight
ratio of the phenoxy resin/tris(acryloyloxyethyl)

isocyanurate, phosphate type acrylate was set to be 60 g/39 g/1 g.

Using this circuit-connecting material, the circuits were connected in the same manner as in

5 Example 1.

Example 16

A mixture obtained by mixing 30 g of 4,4'-bismaleimide diphenylmethane and 35 g of diallylbisphenol A with heating at 120°C for 20 minutes
10 and a phosphate type acrylate (available from Kyoeisha Chemical Co., Ltd.; trade name: P-2m) were used as radical-polymerizable substances.

Phenoxy resin (PKHC) and nitrile rubber (available from Nippon Zeon Co., Ltd.; trade name:
15 NIPOL 1072) were used in a ratio of phenoxy resin/nitrile rubber of 20 g/10 g, and were dissolved in 30 g of methyl ethyl ketone to prepare a solution with a solid content of 50%.

The mixture obtained by mixing 4,4'-bismaleimide
20 diphenylmethane and diallylbisphenol A with heating at 120°C for 20 minutes, the phenoxy resin, the nitrile rubber, the phosphate type acrylate and t-hexyl peroxy-2-ethylhexanoate were formulated in amounts of 69 g, 20 g, 10 g, 1 g and 5 g, respectively, in solid
25 weight ratio, and conductive particles were further mixed and dispersed in an amount of 3 parts by volume.

The subsequent procedure of Example 1 was repeated to obtain a circuit-connecting material.

Using this circuit-connecting material, the circuits were connected in the same manner as in

5 Example 1.

Example 17

A circuit-connecting material was obtained in the same manner as in Example 14 except that a mixture obtained by mixing 30 g of 4,4'-bismaleimide
10 diphenylmethane and 20 g of diallylbisphenol A with heating at 120°C for 20 minutes was used as the radical-polymerizable substance.

Using this circuit-connecting material, the circuits were connected in the same manner as in

15 Example 1.

Example 18

A circuit-connecting material was obtained in the same manner as in Example 1 except that Ni particles having an average particle diameter of 2 μm
20 and surface-coated with Pd (coating thickness: 0.04 μm) were used as the conductive particles and mixed in an amount of 0.5% by volume.

Using this circuit-connecting material, the circuits were connected in the same manner as in

25 Example 1.

Comparative Example

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A circuit-connecting material was obtained in the same manner as in Example 1 except that phenoxy resin (PKHC), bisphenol-A epoxy resin (YL980, trade name of a product of Yuka Shell Epoxy K.K.) and an imidazole type microcapsular curing agent (3941HP, trade name of a product of Asahi Chemical Industry Co., Ltd.) were used and the solid weight ratio of the phenoxy resin/bisphenol-A epoxy resin/imidazole type microcapsular curing agent was set to be 40/20/40.

10 (Measurement of Connection Resistance)

After the circuits were connected, the values of resistance between adjoining circuits of the FPCs having the above connected portion were measured at the initial stage and after keeping for 500 hours in a high-temperature high-humidity chamber of 85°C and 85%RH.

The resistance values were indicated as an average ($\bar{x} + 3\sigma$) of resistance at 150 spots between adjoining circuits. The circuit-connecting material obtained in Example 1 exhibited a good connection reliability. It was also in a low connection resistance at the initial stage and in an only slightly higher resistance after the high-temperature high-humidity test, showing a high durability. The same good reliability as that in Example 1 was also attained in Examples 2 to 18. On the other hand, in Comparative Example, the bonding was in a poor state because of an insufficient curing reaction,

resulting in a high connection resistance at the initial stage.

(Measurement of Adhesive Force)

After the circuits were connected, adhesive
5 force was measured by 90-degree peeling at a peel rate
of 50 mm/minute. In Comparative Example, the curing
reaction was so insufficient that the adhesive force
was as low as about 200 gf/cm in bonding strength. In
Examples 1 to 18, an adhesive force of as good as about
10 1,000 gf/cm was attained.

(Evaluation of Storage Stability)

The circuit-connecting materials obtained were
treated for 30 days in a 30°C thermostatic chamber, and
the circuits were connected in the same manner as the
15 above to evaluate their storage stability.

In all Examples, the results of connection were
obtained which were the same as those in the state
where the circuit-connecting materials were not treated
for 30 days in a 30°C thermostatic chamber (the initial
20 stage).

(Evaluation of Insulating Properties)

Using the above circuit-connecting materials
obtained, a printed-wiring substrate having comb
circuits with alternately arranged 250 lines of copper
25 circuits of 50 μm in line width, 100 μm pitch and 18 μm
thick and a flexible printed circuit board (FPC) having

500 lines of copper circuits of 50 μm in line width, 100 μm pitch and 18 μm thick were connected to each other over a width of 2 mm while heating and pressing them at 160°C and 3 MPa for 10 seconds. A voltage of 100 V was applied to the comb circuits of this connected structure to measure the value of insulation resistance after a 500-hour, 85°C/85%RH high-temperature high-humidity test.

In all Examples, good insulating properties of 109 Ω or above were attained and any lowering of insulating properties was seen.

(Evaluation of Fluidity)

Using a circuit-connecting material of 35 μm thick and 5 mm \times 5 mm in size, this was held between glass sheets of 0.7 mm thick and 15 mm \times 15 mm in size and these were heated and pressed at 150°C and 2 MPa for 10 seconds. The value of fluidity (B)/(A) expressed on the basis of an initial area (A) and an area (B) after heating and pressing was determined to find that it was 1.9 in Example 1, and also within the range of from 1.3 to 3.0 in Examples 2 to 10.

(Modulus of Elasticity After Curing)

The modulus of elasticity at 40°C after curing was measured on the circuit-connecting material of Example 1 to find that it was 1,500 MPa.

(DSC Measurement)

On the circuit-connecting materials obtained,
the exothermic reaction arising temperature (Ta), peak
temperature (Tp) and end temperature (Te) were
determined by means of a differential scanning
5 calorimeter (DSC, manufactured by TA Instrument Co.;
trade name: Model 910) in the measurement at 10°C/min.

In Example 1, the arising temperature (Ta) was
89°C, the peak temperature (Tp) was 103°C and the end
temperature (Te) was 145°C. In Example 2, the arising
10 temperature (Ta) was 87°C, the peak temperature (Tp) was
99°C and the end temperature (Te) was 140°C. In Example
7, the arising temperature (Ta) was 92°C, the peak
temperature (Tp) was 116°C and the end temperature (Te)
was 150°C. In Comparative Example, the arising
15 temperature (Ta) was 86°C, the peak temperature (Tp) was
121°C and the end temperature (Te) was 180°C.

POSSIBILITY OF INDUSTRIAL APPLICATION

As described above, the present invention makes
it possible to provide an electric and electronic
circuit-connecting material having a low-temperature
20 curability superior to, and a longer pot life than,
those of conventional epoxy resin types.

WHAT IS CLAIMED IS:

1 1. A circuit-connecting material which is
2 interposed between circuit electrodes facing each other
3 and electrically connects the electrodes in the
4 pressing direction by pressing the facing electrodes
5 against each other, wherein:

6 said circuit-connecting material comprising as
7 essential components the following components (1) to
8 (3):

9 (1) a curing agent capable of generating free
10 radicals upon heating;

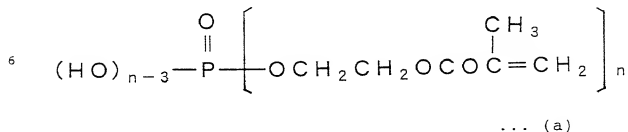
11 (2) a hydroxyl-group-containing resin having a
12 molecular weight of 10,000 or more; and

13 (3) a radical-polymerizable substance.

1 2. The circuit-connecting material according to
2 claim 1, wherein said curing agent capable of
3 generating free radicals upon heating has a 10-hour
4 half-life temperature of 40°C or above and a 1-minute
5 half-life temperature of 180°C or below.

1 3. The circuit-connecting material according to
2 claim 1 or 2, wherein said curing agent capable of
3 generating free radicals upon heating is a peroxyester.

1 4. The circuit-connecting material according to
2 any one of claims 1 to 3, wherein said
3 radical-polymerizable substance comprises a
4 radical-polymerizable substance represented by the
5 following chemical formula (a).



7 wherein n is an integer of 1 to 3.

1 5. The circuit-connecting material according to
2 any one of claims 1 to 4, wherein said
3 hydroxyl-group-containing resin having a molecular
4 weight of 10,000 or more is a phenoxy resin.

1 6. The circuit-connecting material according to
2 any one of claims 1 to 5, wherein said
3 hydroxyl-group-containing resin having a molecular
4 weight of 10,000 or more is a phenoxy resin modified
5 with a carboxyl-group-containing elastomer

1 7. The circuit-connecting material according to
2 any one of claims 1 to 5, wherein said
3 hydroxyl-group-containing resin having a molecular

2 interposed between circuit electrodes facing each other
3 and electrically connects the electrodes in the
4 pressing direction by pressing the facing electrodes
5 against each other, wherein:

6 said circuit-connecting material having, in a
7 measurement with a differential scanning calorimeter
8 (DSC) at 10°C/min., an exothermic reaction arising
9 temperature (Ta) within a range of from 70°C to 110°C, a
10 peak temperature (Tp) of Ta + 5 to 30°C and an end
11 temperature (Te) of 160°C or below.

1 12. The circuit-connecting material according to
2 any one of claims 1 to 11, which contains conductive
3 particles.

1 13. A circuit terminal connected structure
2 comprising a first circuit member having a first
3 connecting terminal and a second circuit member having
4 a second connecting terminal, wherein:

5 said circuit members being disposed in such a
6 way that the first connecting terminal and the second
7 connecting terminal face each other; the
8 circuit-connecting material according to any one of
9 claims 1 to 12 being interposed between the first
10 connecting terminal and the second connecting terminal
11 which face each other; and the first connecting

12 terminal and the second connecting terminal which face
13 each other being electrically connected.

1 14. A circuit terminal connecting method
2 comprising:

3 disposing a first circuit member having a first
4 connecting terminal and a second circuit member having
5 a second connecting terminal, in such a way that the
6 first connecting terminal and the second connecting
7 terminal face each other and interposing the
8 circuit-connecting material according to any one of
9 claims 1 to 12, between the first connecting terminal
10 and the second connecting terminal which face each
11 other, followed by heating and pressing to electrically
12 connect the first connecting terminal and the second
13 connecting terminal which face each other.

1 15. A circuit terminal connected structure
2 comprising a first circuit member having a first
3 connecting terminal and a second circuit member having
4 a second connecting terminal, wherein:

5 said circuit members being disposed in such a
6 way that the first connecting terminal and the second
7 connecting terminal face each other; a
8 circuit-connecting material capable of curing upon
9 radical polymerization being interposed between the

10 first connecting terminal and the second connecting
11 terminal which face each other; the surface of at least
12 one of the first and second connecting terminals being
13 formed of a metal selected from gold, silver, tin and
14 platinum group metals; and the first connecting
15 terminal and the second connecting terminal which face
16 each other being electrically connected.

1 16. A circuit terminal connecting method
2 comprising:
3 disposing a first circuit member having a first
4 connecting terminal and a second circuit member having
5 a second connecting terminal, in such a way that the
6 first connecting terminal and the second connecting
7 terminal face each other and interposing a
8 circuit-connecting material capable of curing upon
9 radical polymerization, between the first connecting
10 terminal and the second connecting terminal which face
11 each other, followed by heating and pressing to
12 electrically connect the first connecting terminal and
13 the second connecting terminal which face each other,
14 wherein:
15 a surface of at least one of said first and
16 second connecting terminals being formed of a metal
17 selected from gold, silver, tin and platinum group
18 metals; and said circuit-connecting material capable of

19 curing upon radical polymerization being formed on one
20 connecting terminal whose surface is formed of the
21 metal selected from gold, silver, tin and platinum
22 group metals, and thereafter the other connecting
23 terminal being registered, followed by the heating and
24 pressing to connect them.

1 17. The circuit terminal connected structure
2 according to claim 15, wherein said circuit-connecting
3 material capable of curing upon radical polymerization
4 is the circuit-connecting material according to any one
5 of claims 1 to 12.

1 18. The circuit terminal connecting method
2 according to claim 16, wherein said circuit-connecting
3 material capable of curing upon radical polymerization
4 is the circuit-connecting material according to any one
5 of claims 1 to 12.

ABSTRACT

A circuit-connecting material which is interposed between circuit electrodes facing each other and electrically connects the electrodes in the pressing direction by pressing the facing electrodes against each other; the circuit-connecting material comprising as essential components (1) a curing agent capable of generating free radicals upon heating, (2) a hydroxyl-group-containing resin having a molecular weight of 10,000 or more and (3) a radical-polymerizable substance. Also provided are a circuit terminal connected structure and a circuit terminal connecting method which make use of such a material.

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FIG. 1

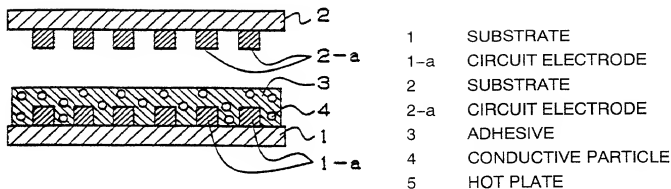
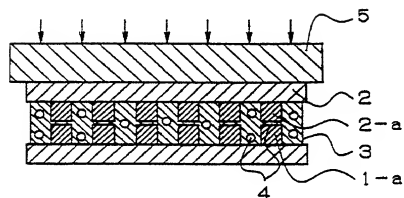


FIG. 2



MAIL DATE CANCELLED
1999

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DECLARATION
AND POWER OF ATTORNEY

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated at 201 et seq. underneath my name.

I believe I am the original, first and sole inventor if only one name is listed at 201 below, or an original, first and joint inventor if plural names are listed at 201 et seq. below, of the subject matter which is claimed and for which a patent is sought on the invention entitled

CIRCUIT-CONNECTING MATERIAL AND CIRCUIT TERMINAL CONNECTED STRUCTURE AND
CONNECTING METHOD

and for which a patent application:

- ☐ is attached hereto and includes amendment(s) filed on _____ (if applicable)
- ☒ was filed in the United States on September 30, 1997 as Application No. 09/462,274 (for declaration not accompanying application) with amendment(s) filed on _____ (if applicable)
- ☒ was filed as PCT international Application No. PCT/JP98/01467 on March 31, 1998 and was amended under PCT Article 19 on April 30, 1998 (if applicable)

I hereby state that I have reviewed and understand the contents of the above identified application, including the claims, as amended by any amendment referred to above.

I acknowledge the duty to disclose information known to me to be material to patentability as defined in Title 37, Code of Federal Regulations, §1.56.

I hereby claim foreign priority benefits under Title 35, United States Codes, § 119(a)-(d) of any foreign application(s) for patent or inventor's certificate listed below and have also identified below any foreign application for patent or inventor's certificate having a filing date before that of the application on which priority is claimed:

EARLIEST FOREIGN APPLICATION(S), IF ANY, FILED PRIOR TO THE FILING DATE OF THE APPLICATION			
APPLICATION NUMBER	COUNTRY	DATE OF FILING (day, month, year)	PRIORITY CLAIMED
09-079422 -	Japan -	31/03/1997	YES <input checked="" type="checkbox"/> NO <input type="checkbox"/>
09-079424 -	Japan -	31/03/1997 -	YES <input checked="" type="checkbox"/> NO <input type="checkbox"/>
09-252933 -	Japan -	18/09/1997 -	YES <input checked="" type="checkbox"/> NO <input type="checkbox"/>

I hereby claim the benefit under Title 35, United States Code, § 119(e) of any United States provisional application(s) listed below.

APPLICATION NUMBER	FILING DATE

I hereby claim the benefit under Title 35, United States Code, §120 of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by the first paragraph of Title 35, United States Code, §112, I acknowledge the duty to disclose information which is material to the patentability as defined in Title 37, Code of Federal Regulations, §1.56 which became available between the filing date of the prior application and the national or PCT international filing date of this application:

APPLICATION SERIAL NO.	FILING DATE	STATUS		
		PATENTED	PENDING	ABANDONED

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I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issuing thereon.

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